(30) Priority data:

593,183

## WORLD INTELLECTUAL PROPERTY ORGANIZATION International Bureau



### INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(51) International Patent Classification <sup>5</sup>:

H04N 5/335, 3/14

(11) International Publication Number: WO 92/06561

(43) International Publication Date: 16 April 1992 (16.04.92)

US

(21) International Application Number: PCT/US91/07043

(22) International Filing Date: 1 October 1991 (01.10.91)

(71) Applicant: E.I. DU PONT DE NEMOURS AND COM-PANY [US/US]; 1007 Market Street, Wilmington, DE 19898 (US).

5 October 1990 (05.10.90)

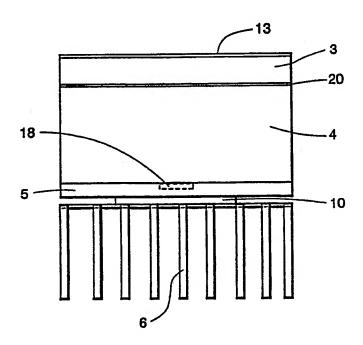
(72) Inventor: BRASINGTON, Frank, Charles; 572 Royal Palm Drive, Melbourne, FL 32935 (US).

(74) Agents: MEDWICK, George, M. et al.; E.I. du Pont de Nemours and Company, Legal/Patent Records Center, 1007 Market Street, Wilmington, DE 19898 (US).

(81) Designated States: AT (European patent), BE (European patent), CA, CH (European patent), DE (European patent), DK (European patent), ES (European patent), FR (European patent), GB (European patent), GR (European patent), IT (European patent), JP, LU (European patent), NL (European patent), SE (European patent).

Published
With international search report.

(54) Title: TEMPERATURE STABILIZATION BUFFER FOR A SOLID STATE ELECTRONIC COMPONENT



(57) Abstract

A thermal buffer (4) is introduced between a thermoelectric cooler (10) and a CCD array (3) in order to provide for uniform temperature distribution throughout the CCD array (3) to stabilize dark current.

#### FOR THE PURPOSES OF INFORMATION ONLY

Codes used to identify States party to the PCT on the front pages of pamphlets publishing international applications under the PCT.

AT	Austria	ES	Spain	MG	Madagascar
AU	Australia	Fl	Finland	ML	Mali
BB	Barbados	FR	France	MN	Mongolia
8E	Belgium	GA	Gabon	MR	Mauritania
BF	Burkina Faso	CB	United Kingdom	MW	Malawi
BG	Bulgaria	GN	Guinca	NL.	Netherlands
BJ	Benin	GR	Greece	NO	Norway
BR	Brazil	HU	Hungary	PL	Poland
CA	Canada	IT	Italy	RO	Romania
CF	Central African Republic	JP	Japan	SD	Sudan
CG	Congo	KP	Democratic People's Republic	SE	Sweden
CH	Switzerland		of Korca	SN	Senegal
CI	Côte d'Ivoire	KR	Republic of Korea	su+	Soviet Union
CM	Cameroon	Li	Liechtenstein	TD	Chad
cs	Czechoslovakia	LK	Sri Lanka	TG	Togo
DE*	Germany	LU	Luxembourg	us	United States of America
DK	Denmark	MC	Monroe	45	Cinica Diates Of Afficiles

<sup>+</sup> Any designation of "SU" has effect in the Russian Federation. It is not yet known whether any such designation has effect in other States of the former Soviet Union.

1

# TEMPERATURE STABILIZATION BUFFER FOR A SOLID STATE ELECTRONIC COMPONENT

#### 5 BACKGROUND OF THE INVENTION

1. Field of Invention

This invention relates to a solid-state device, such as a CCD, where the operating temperature is kept substantially constant to stabilize dark current noise.

10

15

20

2. Description of the Prior Art

When utilizing a solid-state imager to read an image scan, one of the main sources of noise that affects image quality is dark current. In a CCD array, dark current is the amount of ambient current detectable in individual imaging elements when the CCD is energized in the absence of the imaging beam. Typically to minimize the effects of this noise, the dark current in each element of the CCD array is measured prior to a scan and stored as an offset value for later correction of image readings. Technologists working with solid-state imagers wish that the problem of dark current noise were resolved so easily, unfortunately it is not.

25 In the process of scanning an imaging beam across a CCD array, the temperature of the array rises. Dark current noise is known to double for every 10°C or so increase in temperature. An increase in the dark current noise renders offset values determined prior to the scan insufficient to compensate for a growing adverse effect upon image signal resolution. Various attempts have been made to address the temperature—induced rise in dark current.

In U.S. patent 4,551,760, the inventor describes a method of cooling the CCD array to about +10°C to reduce dark current noise. He uses a thermoelectric cooler bonded to the rear surface of the CCD to maintain this low temperature and control the level of dark current attributable noise. However, while the dark current was reduced by the method, he found that condensate was apt to form on the glass face of the CCD interfering with an accurate reading of the image data. In order to avoid the condensate problem, others, who have cooled the CCD even lower, have sought to enclose the "cooled" CCD in a vacuum tight arrangement to minimize the possibility of humidity-induced condensate forming on its viewing surface. These solutions are both difficult and expensive to implement.

The present invention does not require significant cooling of the CCD. As it operates at near room temperature, it is much less susceptible to humidity problems. Consequently, it does not require the energy and expense of evacuating an enclosure and filling it with dry gas to keep the CCD cooled significantly below its operating environment. The present invention is a relatively inexpensive and easily-implementable solution 25 to a well known problem of resolving the floating dark current problem for solid state devices.

#### SUMMARY OF THE INVENTION

10

15

20

35

This invention is based on two fundamental principles. First, it is often important that the 30 temperature of a solid state electronic component, such as a CCD array, remain substantially constant during use. The dark current problem is largely related to the fact that the offset calibration values change while the CCD is in use. The apparatus of Applicant's invention

3

successfully fixes the operating temperature of the CCD array to just below room temperature so that the offset values remain a substantially accurate representation throughout image scanning and may be used to adjust the actual data. This approach has been successfully employed by Applicant in an industrial non-destructive testing radiographic system comprising scanner means, interactive display means, and storage and retrieval means.

10

15

35

).

Secondly, since this invention does not require cooling of the CCD to very low temperatures, it alleviates the time-consuming, costly and difficult measures that were heretofore undertaken to enclose and "refrigerate" the CCD. This invention provides good image signal resolution at near ambient air temperatures.

In an image detecting system comprising a CCD array and a cooling element used to control the temperature of said CCD array, wherein the improvement comprises:

a temperature buffering means interposed in thermal contact between said CCD array and said cooling element.

### 25 DESCRIPTION OF THE DRAWING

Figure 1 represents a prior art approach to cooling of a CCD array.

Figure 2 shows the invention.

Figure 3 is a schematic representation of circuitry 30 employing the invention.

### DETAILED DESCRIPTION OF THE INVENTION

In Figure 2, a heat transfer means 20 is thermally connected to the rear face of solid-state CCD imager 3, that is, opposite the face where the imaging beam is

received. Heat transfer means 20 is utilized to provide a substantially uniform temperature exchange from the rear face of the CCD 3 to heat buffering means 4. To be most effective, the heat transfer means 20, such as a thermal pad or thermally conductive glue, should remain in thermal contact with both heat buffering means 4 and CCD 3.

Heat buffering means 4 is comprised of a relatively highly thermally conductive material, such as aluminum or copper. It extends along the full length of CCD 3 10 and acts to integrate small temperature fluctuations along the CCD. A thermally conductive mounting plate 5 is centered and fixed orthogonal to heat buffering means 4. Thermistor 18 may be placed longitudinally into a 15 grooved out section of mounting plate 5 such that the thermistor thermal contacts both heat buffering means 4 and mounting plate 5. Upon sensing a change in temperature of the heat buffering means, the thermistor's output, which is continuously compared with a reference temperature voltage, triggers the 20 application of sufficient current to cooling element 10 to maintain the reference temperature. This feedback control is accomplished using standard servo amplifier and power control techniques which are well known in the 25 art. See Figure 3.

Cooling element 10 is attached by means of a thermally conductive medium to mounting plate 5 on the side opposite heat buffering means 4. Cooling element 10 might typically be a thermoelectric cooler with the "cool" side fixed to mounting plate 5. The "hot" side of 10 is attached to heat sink 6 to vent away heat during temperature cooling and maintenance.

30

PCT/US91/07043 WO 92/06561

The prior art response to the variable dark current problem can be found in figure 1. The emphasis is upon cooling the CCD array substantially below room temperature to about 10°C. A further definition of the 5 dark current noise problem reveals that acceptable resolution of most signals can be obtained at about room temperature if that temperature can be sustained during imaging of the light source on the CCD. Unless the image signals are very small (e.g. astronomy signals), 10 the key to relative freedom from temperature-dependent dark noise is to maintain a constant temperature so that the offset dark current values, established in the absence of light, will remain useful for making corrections to image data values.

15

25

30

The prior art solution (Fig. 1) bonds the thermoelectric cooling device (312, 314, and 316) directly to non-imaging side of the CCD (220). solution may not be satisfactory in that the size of the cooling device may be smaller than the active area of 20 the CCD array thus permitting uneven cooling. Further, the thermoelectric cooler (TE) itself is not a perfect device and due to manufacturing differences in its internal metallic junctions, there may be differences in temperature across its surface. Also, as heat from the "hot" side of the TE (312) is conducted to cap (214) and conducted away by thermally conductive braid 216, some heat can be transferred to flaps 212 which are bonded to the CCD (210). All of these sources provide an uneven distribution of temperatures across the CCD array and hence change the dark current noise from values measured during offset calibration.

The instant invention avoids the problem of improper sizing of TE 10 to the CCD by extending heat 35

6

transfer means and heat buffering means over the full length of the CCD. The heat buffering means smooths out changes in temperature so that: 1) no one element in the CCD array will experience any substantial difference in temperature from any other element along the array and, 2) any change in temperature will be slight and gradual. Heat buffering means 4 integrates temperature fluctuations and evenly distributes just-below-room temperature coolness of the TE as required. With the thermistor 18 being employed, it can respond to minute changes in temperature. Additionally, the operating temperature of the TE, e.g. 70°F, makes it unlikely that condensate or "dew" will form on imaging window 13 of the CCD. Thus, the substantially constant temperature during imaging of the CCD yields a substantially constant source of dark current noise which can be adequately compensated for through use of measured offset values during calibration.

10

It is understood that the specific components utilized above are for example purposes only for teaching the invention and are not intended to limit the invention. All suitable equivalents should be contemplated as being within the scope of the appended claims.

PCT/US91/07043

What is claimed is:

- 1. In a cooling system for controlling the level of dark current in a solid state electronic component, including a thermoelectric cooler and a temperature feedback control system, the improvement comprising:
- a temperature buffering means, interposed between and in thermal contact with said solid state electronic component and said thermoelectric cooler, for maintaining a substantially uniform temperature throughout said solid state electronic component.
- 15 2. The apparatus recited in claim 1, wherein; said temperature buffering means comprises a block of relatively highly thermally conductive material.
- 3. The apparatus recited in claim 2, wherein said 20 buffering means is made of aluminum.
  - 4. The apparatus recited in claim 2, wherein said buffering means is made of copper.
- 25 5. The apparatus recited in claim 1, wherein said solid state component comprises a CCD array.
- 6. In an image detecting system, comprising a CCD array and a cooling element used to control the temperature of said CCD array, the improvement comprising a temperature buffering means, interposed in thermal contact between said CCD array and said cooling element, for maintaining a substantially uniform temperature throughout the said CCD array.

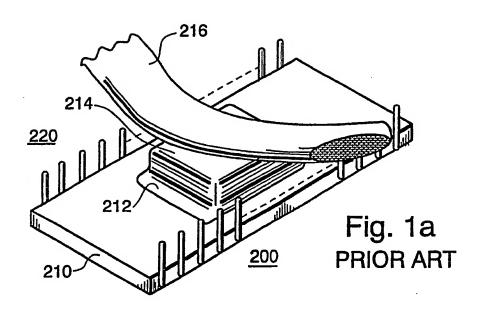
8

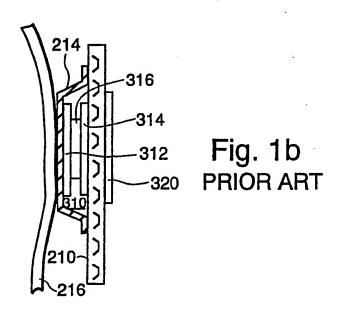
7. In an industrial non-destructive testing reading and storage radiographic system comprising, in combination, scanner means, interactive display means, and storage and retrieval means, the improvement comprising:

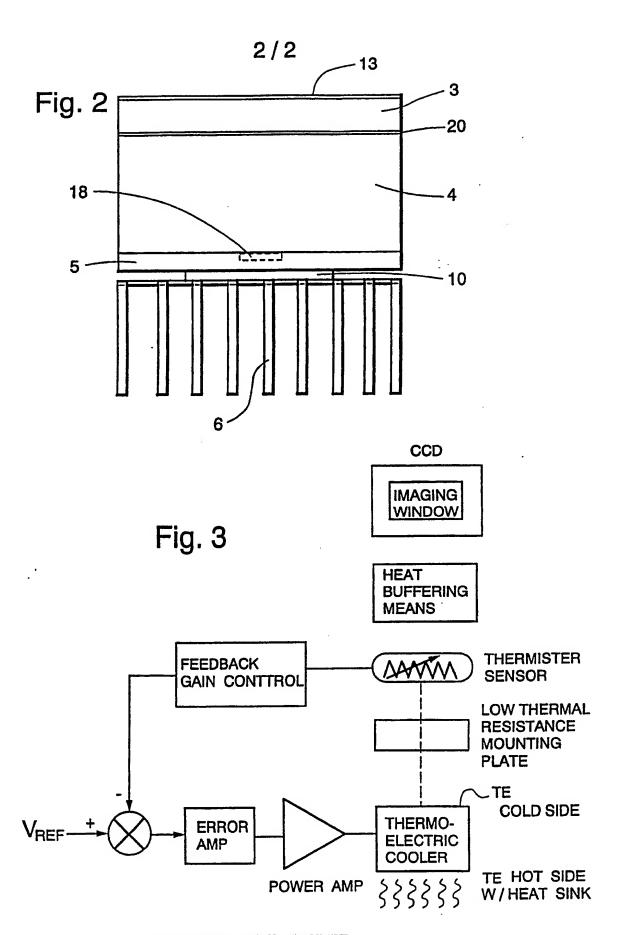
said scanner means including a CCD array thermally coupled to a temperature buffer means interposed between said CCD array and a cooling means.

10

5







SUBSTITUTE SHEET

## INTERNATIONAL SEARCH REPORT

International Application No PCT/US91/07043

I. CLASS	IFICATION OF SUBJECT MATTER (if several classifi	cation symbols apply, indicate all) 3						
According to International Patent Classification (IPC) or to both National Classification and IPC								
IPC (5): HO4N 5/335, HO4N 3/14   U.S.Cl.: 358/213.16,221 357/24LR								
U.S.CI.: 536/213.10,221 537/24LK								
Minimum Documentation Searched 4								
Classification System   Classification Symbols								
358/213.16,213.25,43,221 62/3.2,259.2								
U.S.	357/24LR	204/182.8						
	J) / LILL	204/102:0						
Documentation Searched Other than Minimum Documentation								
	to the Extent that such Documents are included in the Fields Searched 5							
III. DOCUMENTS CONSIDERED TO BE RELEVANT 14								
Category *	Citation of Document, 16 with Indication, where appro	opriate, of the relevant passages 17	Relevant to Claim No. 18					
X Y	US, A, 4,587,563 (BENDALL ET AL See col. 6, lines 63-68 and col		1,5,6					
Y	US, A, 4,551,760 (BENDELL) 05 No See col. 2, lines 37-53.	2-4						
Y	US, A, 4,739,382 (BLOUKE ET AL.) See col. 2, lines 13-58.	1-7						
A	US, A, 4,496,982 (LEVINE) 29 Jan	1-7						
A	US, A, 4,525,743 (WOOD, JR. ET A	1-7						
A	US, A, 4,562,473 (LEVINE) 31 Dec	1-7						
A	US, A, 4,551,762 (LEVINE) 05 Nov	1-7						
A	US, A, 4,580,168 (LEVINE) 01 Apr	1-7						
"A" doc	categories of cited documents: 12 ument defining the general state of the art which is not sidered to be of particular relevance.	"T" later document published after the or priority date and not in conflicted to understand the principle	ct with the application but					
"E" earl film	e; the claimed invention cannot be considered to							
"L" doc whi cita "O" doc	e; the claimed invention in inventive step when the							
othi "P" doc	iment referring to an oral disclosure, use, exhibition or r means iment published prior to the international filing date but than the priority date claimed	document is combined with one ments, such combination being on the art.  "&" document member of the same p	bvious to a person skilled					
	FICATION							
	Actual Completion of the International Search 2	Date of Mailing of this International Sa	arch Banort 2					
07 January 1992  Date of Mailing of this International Search 2  Date of Mailing of this International Search Report 2  80 JAN 1982								
International Searching Authority 1 : Signature of Authorized Officer 20								
ISA/US Glenton Burgess.								